

Application/Control No.	Applicant(s)/Patent under Reexamination			
10/591,135	ITOU ET AL.			
Examiner	Art Unit			
EDUARDO COLON SANTANA	2837			

SEARCHED						
Class	Subclass	Date	Examiner			
318	138, 439, 254, 759	12/20/2007	ECS			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
SEARCH HI	ERENCE STORY SEE HMENT	3/27/2008	ECS	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH plus TEXT SEARCH INCLUDING EPO, JPO AND DERWERT DATABASES	12/20/2007	ECS		
TEXT SEARCH VARIOUS CLASS SEE ATTACHMENT	12/20/2007	ECS		
PLUS SEARCH DONE BY 2800 EIC	12/21/2007	ECS		
UPDATED TEXT SEARCH ABOVE	3/27/2008	ECS		